
**Anodizing of aluminium and its
alloys — Measurement of specular
reflectance and specular gloss of
anodic oxidation coatings at angles of
20°, 45°, 60° or 85°**

*Anodisation de l'aluminium et de ses alliages — Mesurage des
caractéristiques de réflectivité et de brillant spéculaires des couches
anodiques à angle fixe de 20°, 45°, 60° ou 85°*



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Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2 (see www.iso.org/directives).

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For an explanation on the voluntary nature of standards, the meaning of ISO specific terms and expressions related to conformity assessment, as well as information about ISO's adherence to the World Trade Organization (WTO) principles in the Technical Barriers to Trade (TBT) see the following URL: www.iso.org/iso/foreword.html.

This document was prepared by Technical Committee ISO/TC 79, *Light metals and their alloys*, Subcommittee SC 2, *Organic and anodic oxidation coatings on aluminium*.

This third edition cancels and replaces the second edition (ISO 7668:2010), which has been technically revised. The main technical changes are as follows:

- the normative references have been added;
- the definition of specular gloss has been revised;
- the references to CIE spectral luminous efficiency and CIE standard illuminants C and D65 have been added.

Introduction

Specular reflectance and specular gloss are not unique physical properties of a surface. They vary with the angle of measurement, and with the aperture dimensions that define the incident and the reflected beams, such that measurements of these properties are not independent of the apparatus being used.

The specular reflectance of most surfaces increases with the angle of measurement and accounts for the use of reflectometers with various angles as, for example, for painted surfaces. The specular reflectance characteristics of anodized aluminium, however, do not always behave in the normal manner and, because of its property of double reflection, reflected light comes partly from the film surface and partly from the underlying metal. It is advisable to measure the specular reflectance characteristics at 20°, 45°, 60° and 85° to obtain a complete understanding of the specular reflectance properties of the anodized surface, and careful thought should be given to which method or methods are most relevant in any particular situation. The specular reflectance of bright-anodized aluminium with a mirror finish is best measured using 45° or 20° geometry.

Anodizing of aluminium and its alloys — Measurement of specular reflectance and specular gloss of anodic oxidation coatings at angles of 20°, 45°, 60° or 85°

1 Scope

This document specifies methods for the measurement of specular reflectance and specular gloss of flat samples of anodized aluminium using geometries of 20° (Method A), 45° (Method B), 60° (Method C) and 85° (Method D); and of specular reflectance by an additional 45° method (Method E) employing a narrow acceptance angle.

The methods described are intended mainly for use with clear anodized surfaces. They can be used with colour-anodized aluminium, but only with similar colours.

2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

ISO 7583, *Anodizing of aluminium and its alloys — Terms and definitions*

ISO 11664-1, *Colorimetry — Part 1: CIE standard colorimetric observers*

ISO 11664-2, *Colorimetry — Part 2: CIE standard illuminants*

CIE Publication No. 15, *Colorimetry*

3 Terms and definitions

For the purposes of this document, the terms and definitions given in ISO 7583 and the following apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- ISO Online browsing platform: available at <https://www.iso.org/obp>
- IEC Electropedia: available at <http://www.electropedia.org/>

3.1

specular reflectance

ratio of the luminous flux, reflected in the specular direction for a specified source and receptor angle, to the luminous flux of the incident light

Note 1 to entry: Normally expressed as a percentage.